


<b>Search Notes</b>  	<b>Application/Control No.</b>  10542301	<b>Applicant(s)/Patent Under Reexamination</b>  ONO ET AL.
	<b>Examiner</b>  Ren L Yan	<b>Art Unit</b>  2854

SEARCHED			
Class	Subclass	Date	Examiner
101	114,116,127,128.21,128.4,129	5-9-2008	/RY/

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner